




<b>Search Notes</b>  	Application/Control No.  10721876	Applicant(s)/Patent Under Reexamination  LAI ET AL.
	Examiner Lum, Leon Y	Art Unit 1641

Notes	Date	Examiner
Updated search history	06/27/2006	LYL
Patentability Conference	10/27/2006	LYL
Updated search history	11/09/2006	LYL
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<b>Interference Searched</b>  	Application/Control No.  10721876	Applicant(s)/Patent Under Reexamination  LAI ET AL.
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Class	SubClass	Date	Examiner
257	27, 288	11/9/2006	LYL
327	389	11/9/2006	LYL
422	50, 68.1, 82.01, 82.02	11/9/2006	LYL
435	287.1, 287.2, 287.9	11/9/2006	LYL
436	518, 524, 149	11/9/2006	LYL

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	<p>Examiner</p> <p>Lum, Leon Y</p>	<p>Art Unit</p> <p>1641</p>

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